

Application/Control No.	Applicant(s)/Patent under Reexamination
10/657,258	KIM, SOON HAK
Examiner	Art Unit
Sue A Punis	1734

	SEAR	CHED	
Class	Subclass	Date	Examiner
156	230 233-235 240 241 247 277 272.2	8/30/2005	8
	273.3 289		
	275.1		
427	146-151 96	8/30/2005	
438	455 458 584	8/30/2005	
	602 652 660		
	674 677		
430	25-28 195	8/30/2005	
	198 256	•	
	257-262		
	317-320		
	311-313		
	315 325 15		
428	411.1 914	8/30/2005	V

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
156	247	8/30/2005	SP
445	24	8/30/2005)
430	256 257	8/30/2005	
430	/313	8/30/2005	V

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST, PALM Inventor Name Search	8/30/2005	88
Discussed case with previous examiner	8/30/2005	
IPC KW Search of H01J in EAST all databases	8/30/2005	
EAST KW search all databases	8/30/2005	
Basic Search history from EAST attached	8/30/2005	V

Search Notes (continued)

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	SEAR	CHED	
Class	Subclass	Date	Examiner
313	582-587 489 116 117 169.4 282 238	8/30/2005	80
345	60	8/30/2005	
445	24 58	8/30/2005	
156	67	8/30/2005	$ \bigvee$

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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